

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/600,146	ABROL ET AL.	
Examiner	Art Unit	
Soon D. Huun	2616	

SEARCHED						
Subclass	Date	Examiner				
	·					
	:					
		Subclass Date				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			. •		
	-				

(INCLUDING SEARCE	DA <sup>*</sup>	Ť	EXMR
370/229- 231,235,252,253,466,469,320,342,44 1; 709/223-225,227-229	4/25/2	2007	НҮ
·			
:			
:			
· ·			
			•
*			
•			
, ,			
:			
·			
1			